











DLP2021-Q1 ZHCSMH3B - FEBRUARY 2022 - REVISED DECEMBER 2023

DLP2021-Q1 0.2 英寸 16:9 数字微镜器件

1 特性

- 符合汽车应用要求
 - - 40°C 至 105°C 的工作 DMD 阵列温度范围
- 0.2 英寸对角线微镜阵列
 - 7.6µm 微镜间距
 - **±12°**微镜倾斜角(相对于平面)
 - 可减小系统尺寸的侧向照明
- 16:9 (588 × 330) 输入分辨率
- 偏振无关型空间光调制器
- 与 LED 或激光光源兼容
- 低功耗: 260mW(最大值)
- 气密封装
- 80MHz 双倍数据速率 (DDR) 数字微镜器件 (DMD) 接口

2 应用

- 动态地面投影
- 车辆内外视频投影

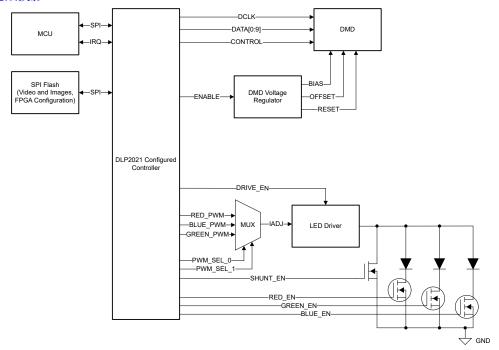
3 说明

DLP2021-Q1 汽车数字微镜器件 (DMD) 专为汽车外部 照明控制和显示应用而设计。应用包括显示全彩色和动 画及动态内容的地面投影。地面投影有助于实现车辆对 行人 (V2P) 通信,例如倒车和车门打开警告,以及协 调车辆通信系统和汽车个性化选项。由于尺寸小且运行 功耗低,采用 DLP2021-Q1 芯片组的投影仪可以支持 很多投影应用。这类投影仪可以安装在车辆上的很多位 置,例如后视镜、车门、尾灯以及前格栅等等。

器件信息

器件型号(1)	封装	封装尺寸 (标称值)
DLP2021-Q1	FQU (64)	8.55mm × 16.80mm

如需了解所有可用封装,请参阅数据表末尾的可订购产品附 录。



DLP2021-Q1 系统方框图



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4 说明(续)

该芯片组能够与 LED 或激光器搭配使用,以生成具有 125% 以上国家电视系统委员会 (NTSC) 色域的高饱和度颜色,并且可以与 RGB 或白色光源搭配使用。DLP2021-Q1 具有现场可编程门阵列 (FPGA) 配置,可用于驱动 DLP2021-Q1 汽车 DMD。此控制器架构专为小型投影仪而设计,不需要视频总线或图形处理单元 (GPU) 即可创建内容。视频和图像内容存储在本地闪存中,上电即可播放,也可根据命令进行播放。

5 Pin Configuration and Functions

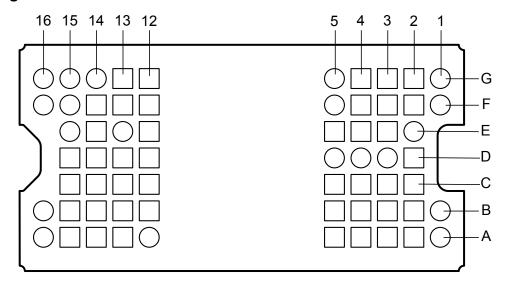


图 5-1. FQU Package 64-Pin LGA Bottom View



表 5-1. Pin Functions

PI	N	衣 5-1. PIN FU		
NAME	NO.	TYPE	DESCRIPTION	
DATA(0)	A2			
DATA(1)	A4			
DATA(2)	B2			
DATA(3)	B3			
DATA(4)	B5			
DATA(5)	C2		Data bus. Synchronous to rising edge and falling edge of DCLK	
DATA(6)	C3			
DATA(7)	B4			
DATA(8)	C5			
DATA(9)	D2			
DCLK	F4		Data clock	
LOADB	F3	LVCMOS input	Parallel latch load enable. Synchronous to rising edge and falling edge of DCLK	
SCTRL	E4	Serial control (sync). Synchronous to risin edge of DCLK		
TRC	F2		Toggle rate control. Synchronous to rising edge and falling edge of DCLK	
DAD_BUS	B15		Reset control serial bus. Synchronous to rising edge of SAC_CLK	
RESET_OEZ	C15		Active low. Output enable signal for internal reset driver circuitry	
RESET_STROBE	B13		Rising edge on RESET_STROBE latches in the control signals	
SAC_BUS	A15		Stepped address control serial bus. Synchronous to rising edge of SAC_CLK	
SAC_CLK	A14		Stepped address control clock	
TEMP_MINUS	G13	Analog input	Calibrated temperature diode used to assist accurate	
TEMP_PLUS	G2	Analog Input	temperature measurements of DMD die	
V _{BIAS}	D15		Power supply for positive bias level of mirror reset signal	
Vcc	A5, B12, C14, D12, F13, G3		Power supply for low voltage CMOS logic. Power supply for normal high voltage at mirror address electrodes. Power supply for offset level of mirror reset signal during power down	
V _{OFFSET}	E14	Power	Power supply for high voltage CMOS logic. Power supply for stepped high voltage at mirror address electrodes. Power supply for offset level of mirror reset signal	
V _{RESET}	D14		Power supply for negative reset level of mirror reset signal	
V _{SS}	A3, A13, B14, C4, C12, C13, D13, E3, E5, E12, F12, F14, G4, G12		Common return for all power	
RESERVED	A1, A12, A16,B1, B16, D3, D4, D5, E2, E13,E15, F1, F5, F15, F16, G1, G5, G14, G15, G16	Reserved	Do not connect.	

6 Specifications

6.1 Absolute Maximum Ratings

See (1)

		MIN	NOM MAX	UNIT
SUPPLY VOLTAGE	'			
V_{DD}	LVCMOS logic supply voltage	- 0.5	2.3	V
V _{OFFSET}	Supply voltage for HVCMOS and micromirror electrode	- 0.5	8.75	V
V _{BIAS}	Supply voltage for micromirror electrode	- 0.5	17	V
V _{RESET}	Supply voltage for micromirror electrode	- 11	0.5	V
V _{BIAS} - V _{OFFSET}	Supply voltage delta (absolute value)		8.75	V
V _{BIAS} - V _{RESET}	Supply voltage delta (absolute value)		28	V
INPUT VOLTAGE				
Input voltage for LVCM	MOS Pins	- 0.5	V _{DD} + 0.5	V
TEMPERATURE DIO	DE			
I _{TEMP_DIODE}	Max current source into temperature diode		500	μA
ENVIRONMENTAL				
T _{ARRAY}	Operating DMD array temperature	- 40	105	°C
ILL _{OVERFILL}	Illumination overfill maximum heat load in area shown in Illumination Overfill Diagram		50	mW/mm ²

⁽¹⁾ Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

6.2 Storage Conditions

Applicable for the DMD as a component or non-operating in a system.

		MIN	MAX	UNIT
T _{stg}	DMD storage temperature	- 40	125	°C

6.3 ESD Ratings

				VALUE		UNIT
,			Human body model (HBM), per AEC	Q100-002 ⁽¹⁾	±1000	V
	V _(ESD)	Electrostatic discharge	Charged device model (CDM), per Al	EC Q100-011	±750	v

⁽¹⁾ AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

6.4 Recommended Operating Conditions

Over operating free-air temperature range (unless otherwise noted)(1)

		MIN	NOM	MAX	UNIT
SUPPLY VOLTAGE I	RANGE				
V_{DD}	Supply voltage for LVCMOS core logic Supply voltage for LPSDR low-speed interface	1.7	1.8	1.95	V
V _{OFFSET}	Supply voltage for HVCMOS and micromirror electrode	8.25	8.5	8.75	V
V _{BIAS}	Supply voltage for mirror electrode	15.5	16	16.5	V
V _{RESET}	Supply voltage for micromirror electrode	- 9.5	- 10	- 10.5	V
V _{BIAS} - V _{OFFSET}	Supply voltage delta (absolute value)			8.75	V
V _{BIAS} - V _{FRESET}	Supply voltage delta (absolute value)			28	V

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6.4 Recommended Operating Conditions (续)

Over operating free-air temperature range (unless otherwise noted)(1)

		MIN	NOM	MAX	UNIT
LVCMOS Buffers	s	'			
V _{IH}	Positive going threshold voltage	0.7		VDD+0.3	x V _{DD}
V _{IL}	Negative going threshold voltage	- 0.3		0.3	x V _{DD}
CLOCK FREQUE	ENCY				
$f_{\sf max}$	Clock frequency for high speed interface SAC_CLK	20	76.2	80	MHz
DCD _{IN}	Duty Cycle Distortion tolerance SAC_CLK	30%		70%	
$f_{\sf max}$	Clock frequency for high speed interface DCLK	20	76.2	80	MHz
DCD _{IN}	Duty Cycle Distortion tolerance DCLK	30%		70%	
TEMPERATURE	DIODE	'			
I _{TEMP_DIODE}	Max current source into temperature diode			120	μА
ENVIRONMENTA	AL	'			
T _{ARRAY}	Operating DMD array temperature ⁽³⁾	- 40		105	°C
ILL _{UV}	Illumination, wavelength < 395 nm ⁽²⁾			2	mW/cm ²
ILL _{OVERFILL}	Illumination overfill maximum heat load in area shown in Illumination Overfill Diagram			40	mW/mm ²

- (1) Recommended Operating Conditions are applicable after the DMD is installed in the final product.
- (2) The maximum operation conditions for operating temperature and UV illumination shall not be implemented simultaneously.
- (3) Operating profile information for device micromirror landed duty-cycle and temperature may be provided if requested.

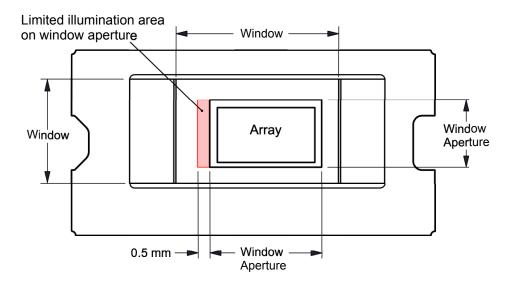


图 6-1. Illumination Overfill Diagram

6.5 Thermal Information

	THERMAL METRIC	VALUE	UNIT
Thermal resistance	Active area-to-test point 1 (TP1) (1)	5	°C/W

(1) The DMD is designed to conduct absorbed and dissipated heat to the back of the package. The cooling system must be capable of maintaining the package within the temperature range specified in the Recommended Operating Conditions. The total heat load on the DMD is largely driven by the incident light absorbed by the active area, although other contributions include light energy absorbed by the window aperture and electrical power dissipation of the array. Optical systems should be designed to minimize the light energy

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falling outside the window clear aperture since any additional thermal load in this area can significantly degrade the reliability of the device.

6.6 Electrical Characteristics

Over operating free-air temperature range (unless otherwise noted) (1)

	PARAMETER	TEST CONDITIONS	MIN	TYP MAX	UNIT
CURRENT					
I _{DD}	Supply current: V _{DD}	V _{DD} = 1.95 V		30	mA
I _{OFFSET}	Supply current: V _{OFFSET}	V _{OFFSET} = 8.75 V		15	mA
I _{BIAS}	Supply current: V _{BIAS}	V _{BIAS} = 16.5 V		2.3	mA
I _{RESET}	Supply current: V _{RESET}	V _{RESET} = - 10.5 V		3.3	mA
POWER	'				
P _{DD}	Supply power dissipation: V _{DD}	V _{DD} = 1.95 V		60	mW
P _{OFFSET}	Supply power dissipation: V _{OFFSET}	V _{OFFSET} = 8.75 V		132	mW
P _{BIAS}	Supply power dissipation: V _{BIAS}	V _{BIAS} = 16.5 V		38	mW
P _{RESET}	Supply power dissipation: V _{RESET}	V _{RESET} = - 10.5 V		30	mW
P _{TOTAL}	Supply power dissipation: Total			260	mW
LVCMOS E	Buffers		1		
V _{OH}	High level output voltage	I _{OH} = -2 mA	0.8 × V _{DD}		V
V _{OL}	Low level output voltage	I _{OH} = 2 mA		0.2 × V _{DD}	V
I _{IL}	Low level input current ⁽²⁾	VDD = 1.95 V; V _I = 0 V	- 100		nA
I _{IH}	High level output current ⁽²⁾	VDD = 1.95 V; V _I = 1.95 V		135	uA
I _{IL2}	Low level input current ⁽³⁾	V _{DD} = 0.0 V	- 5		uA
I _{IH2}	High level output current ⁽³⁾	V _{DD} = 1.95 V		785	uA
CAPACITA	NCE				
C _{IN}	Input capacitance	f = 1 MHz		10	pF
C _{OUT}	Output capacitance	f = 1 MHz		15	pF
C _{TEMP}	Temperature sense diode capacitance	f = 1 MHz		25	pF

- (1) Device electrical characteristics are over Recommended Operating Conditions unless otherwise noted.
- (2) Specification is for LVCMOS input pins which do not have pull up or pull down resistors.
- (3) Specification is for LVCMOS input pins which do have pull down resistors.

6.7 Timing Requirements

Device electrical characteristics are over Recommended Operating Conditions unless otherwise noted

		MIN	NOM	MAX	UNIT
DMD MIRROR AND SRAM	CONTROL LOGIC SIGNALS		-	•	
t _{su}	Setup time SAC_BUS low before SAC_CLK ↑	1			ns
t _h	Hold time SAC_BUS low after SAC_CLK ↑	1			ns
t _{su}	Setup time DAD_BUS high before SAC_CLK ↑	1			ns
t _h	Hold time DAD_BUS high after SAC_CLK ↑	1			ns
DMD DATA PATH AND LO	GIC CONTROL SIGNALS			•	
t _{su}	Setup time DATA(9:0) before DCLK ↑ or DCLK ↓	1.0			ns
t _h	Hold time DATA(9:0) after DCLK ↑ or DCLK ↓	1.0			ns
t _{su}	Setup time SCTRL before DCLK ↑ or DCLK ↓	1.0			ns
t _h	Hold time SCTRL after DCLK ↑ or DCLK ↓	1.0			ns
t _{su}	Setup time TRC before DCLK ↑ or DCLK ↓	1.0			ns

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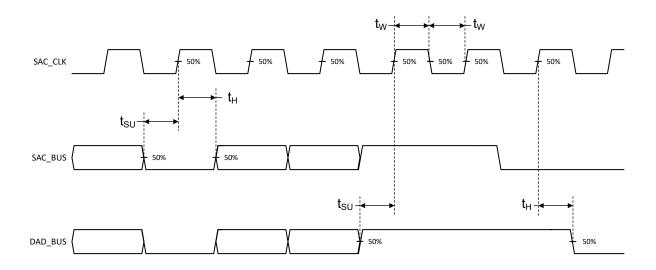
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6.7 Timing Requirements (续)

Device electrical characteristics are over Recommended Operating Conditions unless otherwise noted

		MIN	NOM M	AX	UNIT
t _h	Hold time TRC after DCLK ↑ or DCLK ↓	1.0			ns
t _{su}	Setup time LOADB low before DCLK ↑ or DCLK ↓	1.0			ns
t _h	Hold time LOADB low after DCLK ↑ or DCLK ↓	1.0			ns
t _{su}	Setup time RESET_STROBE high before DCLK ↑ or DCLK ↓	1.5			ns
t _h	Hold time RESET_STROBE high after DCLK ↑ or DCLK ↓	1.5			ns
t _w	Pulse width 50% to 50% reference points: DCLK high or low	5			ns
t _w	pulse width 50% to 50% reference points: LOADB low	7			ns
t _w	pulse width 50% to 50% reference points: RESET_STROBE high	7			ns
t _r	Rise time 20% to 80% reference points: DCLK, DATA, SCTRL, TRC, LOADB,SAC_CLK			2.5	ns
t _f	Fall time 80% to 20% reference points: DCLK, DATA, SCTRL, TRC, LOADB,SAC_CLK			2.5	ns



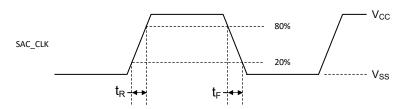
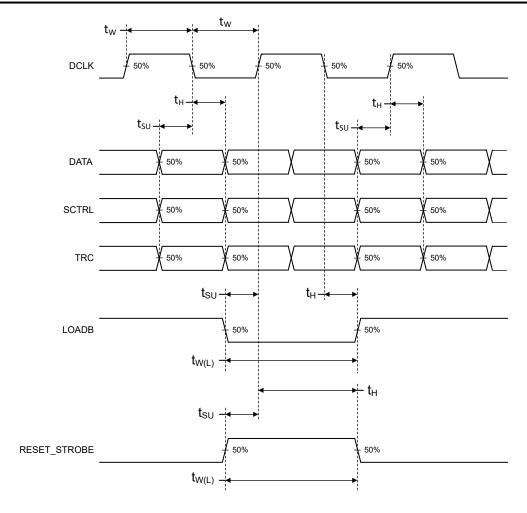


图 6-2. DMD Mirror and SRAM Control Logic Timing Requirements





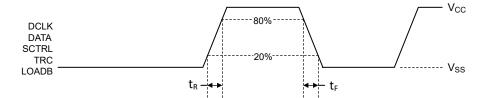


图 6-3. DMD Data Path and Control Logic Timing Requirements

6.8 System Mounting Interface Loads

	PARAMETER					
Thermal Interface Area Uniformly distributed within the Thermal Interface Area shown in 图 6-4				70	N	
Electrical Interface Area	Uniformly distributed within the Electrical Interface Area shown			100	IN	

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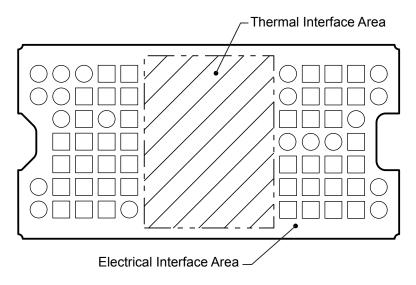


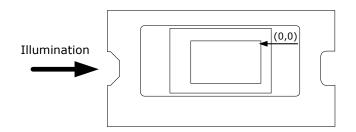
图 6-4. System Interface Loads

6.9 Micromirror Array Physical Characteristics

	PARAMETER	PARAMETER V							
М	Number of active columns ⁽¹⁾		416	micromirrors					
N	Number of active rows ⁽¹⁾		468	micromirrors					
ε	Micromirror Pitch (diagonal) ⁽²⁾		7.6	μm					
Р	Micromirror Pitch (horizontal and vertical) ⁽²⁾		10.8	μm					
	Micromirror active array width	(P × M) + (P / 2)	4.498	mm					
	Micromirror active array height	(P × N) / 2 + (P / 2)	2.533	mm					
	Micromirror active border	Pond of micromirrors (POM) (3)	10	micromirrors/side					

- (1) See Array Physical Characteristics.
- (2) See Pixel Pitch.
- (3) The structure and qualities of the border around the active array include a band of partially functional micromirrors called the POM. These micromirrors are structurally and electrically prevented from tilting toward the bright or ON state, but still require an electrical bias to tilt toward OFF.





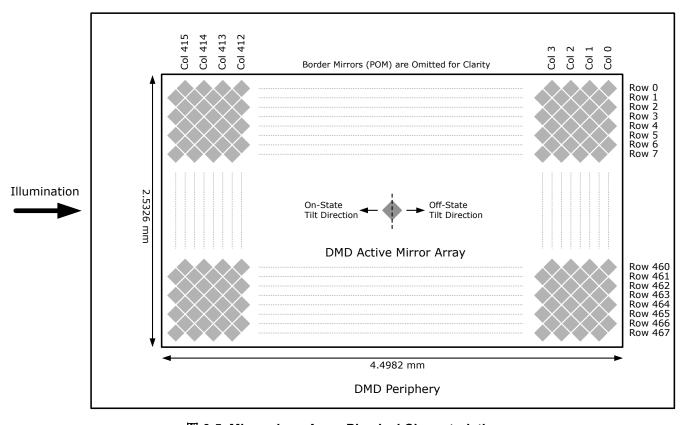


图 6-5. Micromirror Array Physical Characteristics



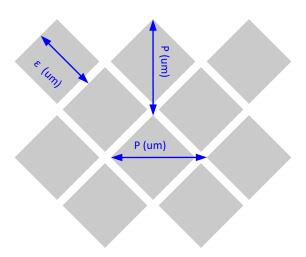


图 6-6. Mirror (Pixel) Pitch

6.10 Micromirror Array Optical Characteristics

PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
Micromirror tilt angle	DMD landed state ⁽¹⁾	11	12	13	degree
DMD efficiency ⁽²⁾	420 nm - 700 nm		66%		

(1) Measured relative to the plane formed by the overall micromirror array at 25°C

DMD efficiency is measured photopically under the following conditions: 24° illumination angle, F/2.4 illumination and collection apertures, uniform source spectrum (halogen), uniform pupil illumination, the optical system is telecentric at the DMD, and the efficiency numbers are measured with 100% electronic micromirror landed duty-cycle and do not include system optical efficiency or overfill loss. This number is measured under conditions described above and deviations from these specified conditions could result in a different efficiency value in a different optical system. The factors that can influence the DMD efficiency related to system application include: light source spectral distribution and diffraction efficiency at those wavelengths (especially with discrete light sources such as LEDs or lasers), and illumination and collection apertures (F/#) and diffraction efficiency. DLPA083A describes the interaction of these system factors, as well as the DMD efficiency factors that are not system dependent.

6.11 Window Characteristics

PARAM	ETER	MIN	NOM	MAX	UNIT
Window material designation		Co	orning Eagle XG		
Window refractive index	at wavelength 546.1 nm		1.5119		
Window aperture (1)				See (1)	

(1) See the mechanical package ICD for details regarding the size and location of the window aperture.

6.12 Chipset Component Usage Specification

The DLP2021-Q1 DMD is a component of a Texas Instruments DLP® chipset including a DLP products controller. Reliable function and operation of the DMD requires that it be used in conjunction with a DLP products controller.

备注

TI assumes no responsibility for image quality artifacts or DMD failures caused by optical system operating conditions exceeding limits described previously.

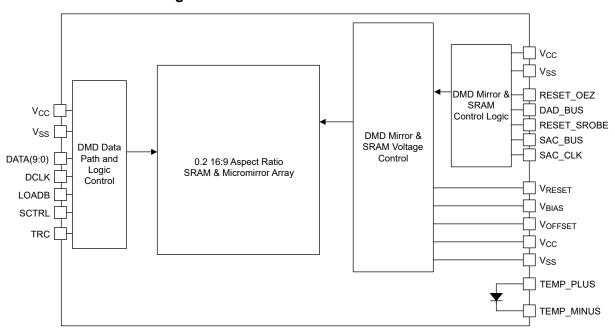
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7 Detailed Description

7.1 Overview

The DLP2021-Q1 DMD has a resolution of 416×468 mirrors configured in a diamond format that results in an aspect ratio of 16:9 which creates an effective resolution of 588×330 square pixels. By configuring the pixels in a diamond format, the illumination input to the DMD enters from the side allowing for smaller mechanical packaging of the optical system.

7.2 Functional Block Diagram



7.3 Feature Description

To ensure reliable operation, the DLP2021-Q1 DMD must be used with a DLP products controller.

7.3.1 Micromirror Array

The DLP2021-Q1 DMD consists of a two-dimensional array of 1-bit CMOS memory cells that determine the state of the each of the 416 \times 468 micromirrors in the array. Refer to % 6.9 section for a calculation of how the 416 \times 468 micromirror array represents a 16:9 dimensional aspect ratio to the user. Each micromirror is either ON (tilted +12°) or OFF (tilted - 12°). Combined with appropriate projection optical system the DMD can be used to create sharp, colorful, and vivid digital images.

7.3.2 Double Data Rate (DDR) Interface

Each DMD micromirror and its associated SRAM memory cell is loaded with data from the DLP controller via the DDR interface (DATA(9:0), DCLK, LOADB, SCRTL, and TRC). These signals are low voltage CMOS nominally operating at 1.8-V level to reduce power and switching noise. This high speed data input to the DMD allows for a maximum update rate of the entire micromirror array to be nearly 5 kHz, enabling the creation of seamless digital images using Pulse Width Modulation (PWM).

7.3.3 Micromirror Switching Control

Once data is loaded onto the DMD, the mirrors switch position (+12° or - 12°) based on the timing signal sent to the DMD Mirror and SRAM control logic. The DMD mirrors will be switched from OFF to ON or ON to OFF, or stay in the same position based on control signals DAD_BUS, RESET_STROBE, SAC_BUS, and SAC_CLK, which are coordinated with the data loading by the DLP controller. In general, the DLP controller loads the DMD SRAM memory cells over the DDR interface, and then commands to the micromirrors to switch position.

At power down, the DMD Mirrors are commanded by the DLP controller to move to a near flat (0°) position as shown in $\dagger 9$. The flat state position of the DMD mirrors are referred to as the "Parked" state. To maintain long-term DMD reliability, the DMD must be properly "Parked" prior to every power down of the DMD power supplies.

7.3.4 DMD Voltage Supplies

The micromirrors switching requires unique voltage levels to control the mechanical switching. These voltages levels are nominally 16 V, 8.5 V, and $^-$ 10 V (V_{BIAS}, V_{OFFSET}, and V_{RESET}). The specification values for V_{BIAS}, V_{OFFSET}, and V_{RESET} are shown in $^+$ 6.4.

7.3.5 Logic Reset

Reset of the DMD is required and controlled by the DLP products controller.

7.3.6 Temperature Sensing Diode

The DMD includes a temperature sensing diode designed to be used with the TMP411-Q1 or equivalent temperature monitoring device.

☑ 7-1 shows the typical connection between the DLP products controller, TMP411-Q1, and the DLP2021-Q1 DMD. The signals to the temperature sense diode are sensitive to system noise, and care should be taken in the routing and implementation of this circuit. See the TMP411-Q1 Data Sheet for detailed PCB layout recommendations.

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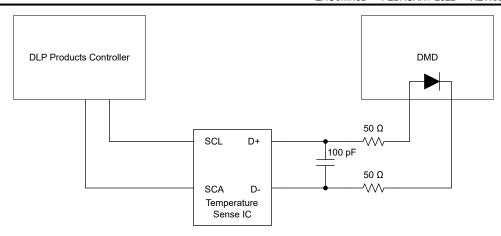


图 7-1. Temperature Sense Diode Typical Circuit Configuration

It is recommended that the host controller manage parking of the DMD based on the allowable temperature specifications and temperature measurements.

7.3.6.1 Temperature Sense Diode Theory

A temperature sensing diode is based on the fundamental current and temperature characteristics of a transistor. The diode is formed by connecting the transistor base to the collector. Two different known currents flow through the diode and the resulting diode voltage is measured in each case. The difference in the base-emitter voltages is proportional to the absolute temperature of the transistor.

Refer to the *TMP411-Q1 Data Sheet* for detailed information about temperature diode theory and measurement.

8 7-2 and 7-3 illustrate the relationship between the current and voltage through the diode.

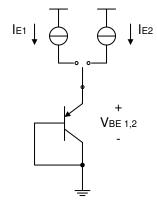


图 7-2. Temperature Measurement Theory

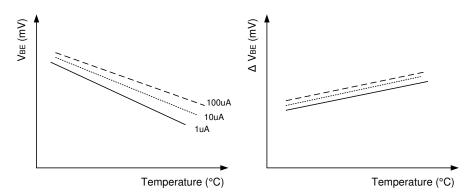


图 7-3. Example of Delta VBE vs. Temperature

7.4 System Optical Considerations

Optimizing system optical performance and image performance strongly relates to optical system design parameter trades. Although it is not possible to anticipate every conceivable application, projector image quality and optical performance is contingent on compliance to the optical system operating conditions described in the following sections.

7.4.1 Numerical Aperture and Stray Light Control

The angle defined by the numerical aperture of the illumination and projection optics at the DMD optical area should be the same. This angle should not exceed the nominal device mirror tilt angle unless appropriate apertures are added in the illumination and/or projection pupils to block flat-state and stray light from passing through the projection lens. The mirror tilt angle defines DMD capability to separate the "On" optical path from any other light path, including undesirable flat-state specular reflections from the DMD window, DMD border structures, or other system surfaces near the DMD such as prism or lens surfaces. If the numerical aperture exceeds the mirror tilt angle, or if the projection numerical aperture angle is more than two degrees larger than the illumination numerical aperture angle, contrast ratio can be reduced and objectionable artifacts in the image border and/or active area could occur.

7.4.2 Pupil Match

TI's optical and image quality specifications assume that the exit pupil of the illumination optics is nominally centered within two degrees of the entrance pupil of the projection optics. Misalignment of pupils can create objectionable artifacts in the image border and/or active area, which may require additional system apertures to control, especially if the numerical aperture of the system exceeds the pixel tilt angle.

7.4.3 Illumination Overfill and Alignment

Overfill light illuminating the area outside the active array can create artifacts from the mechanical features and other surfaces that surround the active array. These artifacts may be visible in the projected image. The illumination optical system should be designed to minimize light flux incident outside the active array and on the window aperture. Depending on the particular system's optical architecture and assembly tolerances, this amount of overfill light on the area outside of the active array may still cause artifacts to be visible. Illumination light and overfill can also induce undesirable thermal conditions on the DMD, especially if illumination light impinges directly on the DMD window aperture or near the edge of the DMD window. Refer to † 6.4 for a specification on this maximum allowable heat load due to illumination overfill.

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7.5 DMD Image Performance Specification

PARAMETER		MIN	UNIT		
Number of non-operational micromirrors ⁽¹⁾	Adjacent micromirrors			0	micromirrors
Number of non-operational microminors	Non-adjacent micromirrors			10	THICIOITHITOIS
Optical performance		S	ee 节 7.4 .		

(1) A non-operational micromirror is defined as a micromirror that is unable to transition between the on-state and off-state positions.

7.6 Micromirror Array Temperature Calculation

Active array temperature can be computed analytically from measurement points on the outside of the package, the package thermal resistance, the electrical power, and the illumination heat load.

Relationship between array temperature and the reference ceramic temperature (thermocouple location TP1 in [8] 7-4) is provided by the following equations.

$$T_{ARRAY} = T_{CERAMIC} + (Q_{ARRAY} \times R_{ARRAY-TO-CERAMIC})$$
 (1)

$$Q_{ARRAY} = Q_{ELECTRICAL} + Q_{ILLUMINATION}$$
 (2)

where

- T_{ARRAY} = computed DMD array temperature (°C)
- T_{CERAMIC} = measured ceramic temperature (TP1 location in 图 7-4) (°C)
- R_{ARRAY-TO-CERAMIC} = DMD package thermal resistance from array to TP1 (°C/watt) (see 节 6.5)
- Q_{ARRAY} = total power, electrical plus absorbed, on the DMD array (watts)
- Q_{ELECTRICAL} = nominal electrical power dissipation by the DMD (watts)
- $Q_{ILLUMINATION} = (C_{L2W} \times S_L)$
- C_{L2W} = conversion constant for screen lumens to power on the DMD (watts/lumen)
- S_I = measured screen lumens (lm)

Electrical power dissipation of the DMD is variable and depends on the voltages, data rates, and operating frequencies.

Absorbed power from the illumination source is variable and depends on the operating state of the mirrors and the intensity of the light source.

Equations shown previous are valid for a 1-chip DMD system with total projection efficiency from DMD to the screen of 87%.

The constant C_{L2W} is based on the DMD array characteristics. It assumes a spectral efficiency of 300 lumens/ watt for the projected light and illumination distribution of 83.7% on the active array, and 16.3% on the array border.

Sample calculation:

- $S_1 = 50 \text{ Im}$
- $C_{1.2W} = 0.00293 \text{ W/Im}$
- Q_{FLFCTRICAL} = 0.105 W
- R_{ARRAY-TO-CERAMIC} = 5°C/W
- T_{CERAMIC} = 55°C

$$Q_{ARRAY} = 0.105 \text{ W} + (0.00293 \times 50 \text{ lm}) = 0.252 \text{ W}$$
 (3)

$$T_{ARRAY} = 55^{\circ}C + (0.252 \text{ W} \times 5^{\circ}C/\text{W}) = 56.26^{\circ}C$$
 (4)



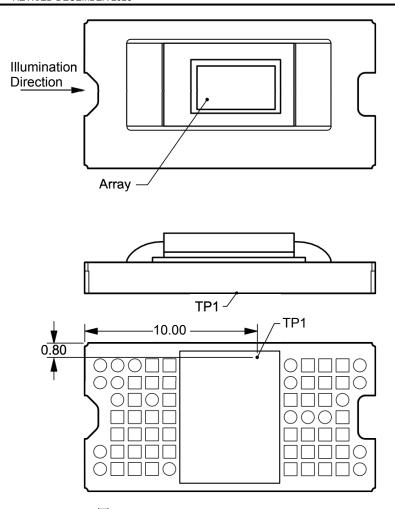


图 7-4. Thermocouple Location

7.7 Micromirror Landed-On/Landed-Off Duty Cycle

The micromirror landed-on/landed-off duty cycle (landed duty cycle) denotes the amount of time (as a percentage) that an individual micromirror is landed in the ON state versus the amount of time the same micromirror is landed in the OFF state.

As an example, assuming a fully saturated white pixel, a landed duty cycle of 90/10 indicates that the referenced pixel is in the ON state 90% of the time (and in the OFF state 10% of the time), whereas 10/90 would indicate that the pixel is in the OFF state 90% of the time. Likewise, 50/50 indicates that the pixel is ON 50% of the time and OFF 50% of the time.

Note that when assessing landed duty cycle, the time spent switching from one state (ON or OFF) to the other state (OFF or ON) is considered negligible and is thus ignored.

Since a micromirror can only be landed in one state or the other (ON or OFF), the two numbers (percentages) always add to 100.

8 Application and Implementation

备注

以下应用部分中的信息不属于 TI 器件规格的范围, TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计,以确保系统功能。

8.1 Application Information

The DLP2021-Q1 DMD was designed to be used in automotive applications such as dynamic ground projection. The information shown in this section describes the dynamic ground projection application.

8.2 Typical Application

The DLP2021-Q1 DMD combined with a DLP products controller are the primary devices that make up the reference design for a dynamic ground projection system as shown in the block diagram

8 8-1.

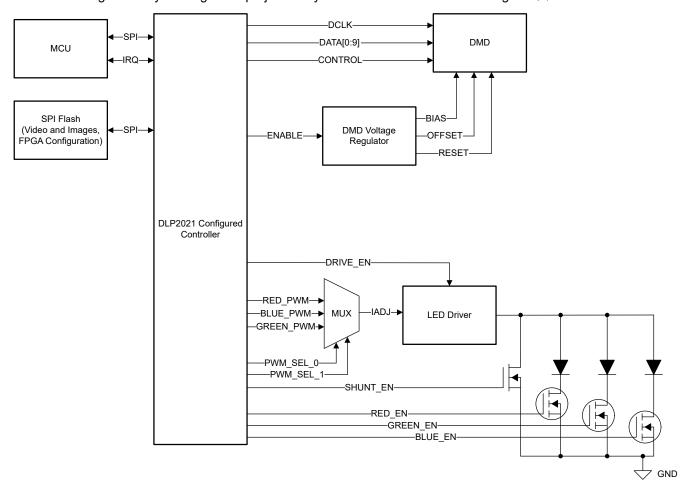


图 8-1. Dynamic Ground Projection System Block Diagram

In this architecture, video content is compressed and stored in external flash memory. Low speed SPI commands are sent from a microcontroller or other processor to the DLP products controller to indicate what video content to read from external memory. Storing the video content in memory removes the need for a high speed video interface to the module which improves compatibility with typical vehicle infrastructures. It also decreases overall system size and cost by removing graphics generation and interfaces. The controller decompresses each bit plane of the video data (416 × 468 resolution) and displays them on the DMD in rapid

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succession to create the full video image. Due to the diamond format of the DMD pixels, the output image has an effective resolution of 588×330 . The controller synchronizes the DMD bit plane data with the RGB enable timing for the LED color controller and driver circuit.

The controller may connect to a TMP411-Q1 to measure the DLP2021-Q1 temperature using the built-in temperature sensing diode.

The controller combined with the DLP2021-Q1 may be used in RGB LED or laser illumination systems, or in single-color systems as shown in

8-2.

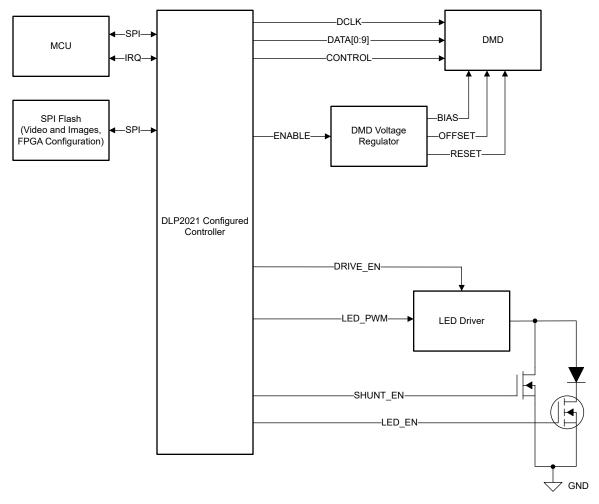


图 8-2. Dynamic Ground Projection System Block Diagram - Single Color

8.3 Application Mission Profile Consideration

Each application is anticipated to have different mission profiles, or number of operating hours at different temperatures. To assist in evaluation, the automotive DMD reliability lifetime estimates Application Report may be provided. See the TI Application team for more information.

9 Power Supply Recommendations

9.1 Power Supply Sequencing Requirements

V_{BIAS}, V_{CC}, V_{OFFSET}, V_{RESET}, V_{SS} are required to operate the DMD.

小心

- For reliable operation of the DMD, the following power supply seguencing requirements must be followed. Failure to adhere to the prescribed power up and power down procedures may affect
- The V_{CC}, V_{OFFSET}, V_{BIAS}, and V_{RESET} power supplies have to be coordinated during power up and power down operations. Failure to meet any of the following requirements will result in a significant reduction in the DMD's reliability and lifetime. Refer to 图 9-1. V_{SS} must also be connected.

DMD Power Supply Power Up Procedure:

- During power up, V_{CC} must always start and settle before V_{OFFSET}, V_{BIAS} and V_{RESET} voltages are applied to the DMD.
- During power up, V_{BIAS} does not have to start after V_{OFFSET}. However, it is a strict requirement that the delta between V_{BIAS} and V_{OFESET} must be within ±8.75 V (refer to Note 1 for 图 9-1).
- During power up, the DMD's LVCMOS input pins shall not be driven high until after V_{CC} has settled at operating voltage.
- During power up, there is no requirement for the relative timing of V_{RESET} with respect to V_{OFFSET} and V_{BIAS}.
- Power supply slew rates during power up are flexible, provided that the transient voltage levels follow the requirements listed previously in 节 6.4 and in 图 9-1.

DMD Power Supply Power Down Procedure

- V_{CC} must be supplied until after V_{BIAS}, V_{RESET}, and V_{OFFSET} are discharged to within 4 V of ground.
- During power down it is not mandatory to stop driving V_{BIAS} prior to V_{OFFSET}, but it is a strict requirement that the delta between V_{BIAS} and V_{OFFSET} must be within ±8.75 V (refer to Note 1 for $\boxed{8}$ 9-1).
- During power down, the DMD's LVCMOS input pins must be less than V_{CC} + 0.3 V.
- During power down, there is no requirement for the relative timing of V_{RESET} with respect to V_{OESSET} and
- · Power supply slew rates during power down are flexible, provided that the transient voltage levels follow the requirements listed previously in 节 6.4 and in 图 9-1.

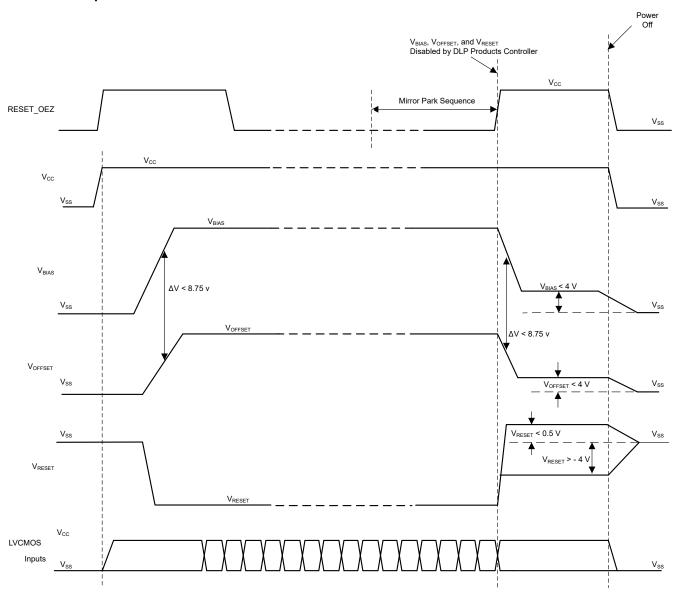
Product Folder Links: DLP2021-Q1

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9.1.1 Power Up and Power Down



A. ± 8.75 -V delta, Δ V, shall be considered the max operating delta between V_{BIAS} and V_{OFFSET} . Customers may find that the most reliable way to ensure this is to power V_{OFFSET} prior to V_{BIAS} during power up and to remove V_{BIAS} prior to V_{OFFSET} during power down.

图 9-1. Power Supply Sequencing Requirements (Power Up and Power Down)

10 Layout

10.1 Layout Guidelines

For specific DMD PCB guidelines, use the following:

- V_{CC} should have at least 1 × 2.2-μF and 4 × 0.1-μF capacitors evenly distributed among the 6 V_{CC} pins.
- A 0.1-μF, X7R rated capacitor should be placed near every pin for V_{BIAS}, V_{RSET}, and V_{OFF}.

10.2 Temperature Diode Pins

The DMD has an internal diode (PN junction) that is intended to be used with an external TI TMP411-Q1 or equivalent temperature sensing IC. PCB traces from the DMD's temperature diode pins to the TMP411-Q1 are sensitive to noise. See the TMP411-Q1 data sheet for specific routing recommendations.

Product Folder Links: DLP2021-Q1

Avoid routing the temperature diodes signals near other traces to reduce coupling of noise onto these signals.



11 Device and Documentation Support

11.1 Device Support

11.1.1 Device Nomenclature

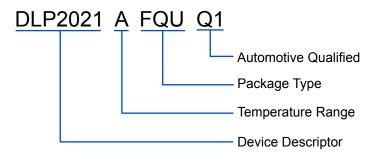


图 11-1. Part Number Description

11.1.2 Device Markings

The device marking is shown in 🖺 11-2. The marking will include both human-readable information and a 2-dimensional matrix code. The human-readable information is described in 🖺 11-1. The 2-dimensional matrix code is an alpha-numeric character string that contains the DMD part number and lot trace code.

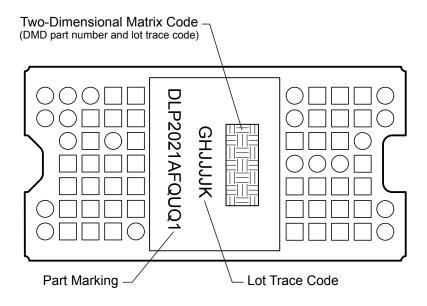


图 11-2. DMD Marking

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11.2 Documentation Support

11.2.1 Related Documentation

For related documentation see the following:

- Texas Instruments, TMP411-Q1 ±1°C Remote and Local Temperature Sensor With N-Factor and Series Resistance Correction data sheet
- Texas Instruments, DMD Optical Efficiency for Visible Wavelengths application report

11.3 接收文档更新通知

要接收文档更新通知,请导航至 ti.com 上的器件产品文件夹。点击*通知* 进行注册,即可每周接收产品信息更改摘要。有关更改的详细信息,请查看任何已修订文档中包含的修订历史记录。

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ESD 的损坏小至导致微小的性能降级,大至整个器件故障。精密的集成电路可能更容易受到损坏,这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

11.7 Device Handling

The DMD is an optical device so precautions should be taken to avoid damaging the glass window. Please see the DMD Handling application note for instructions on how to properly handle the DMD.

11.8 术语表

TI术语表本术语表列出并解释了术语、首字母缩略词和定义。

12 Revision History

注:以前版本的页码可能与当前版本的页码不同

Changes from Revision A (November 2022) to Revision B (December 2023)Page• 将数据表从"预告信息"更改为"量产数据"1• Changed figure link of human-readable information24

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
	(1)	(2)			(0)	(4)	(5)		(0)
DLP2021AFQUQ1	Active	Production	CLGA (FQU) 64	126 JEDEC TRAY (5+1)	Yes	Call TI	N/A for Pkg Type	-40 to 105	
DLP2021AFQUQ1.A	Active	Production	CLGA (FQU) 64	126 JEDEC TRAY (5+1)	Yes	Call TI	N/A for Pkg Type	-40 to 105	
DLP2021AFQUQ1.B	Active	Production	CLGA (FQU) 64	126 JEDEC TRAY (5+1)	-	Call TI	Call TI	-40 to 105	

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

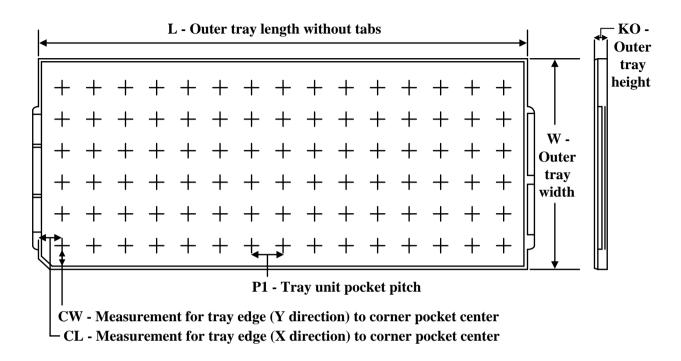
⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



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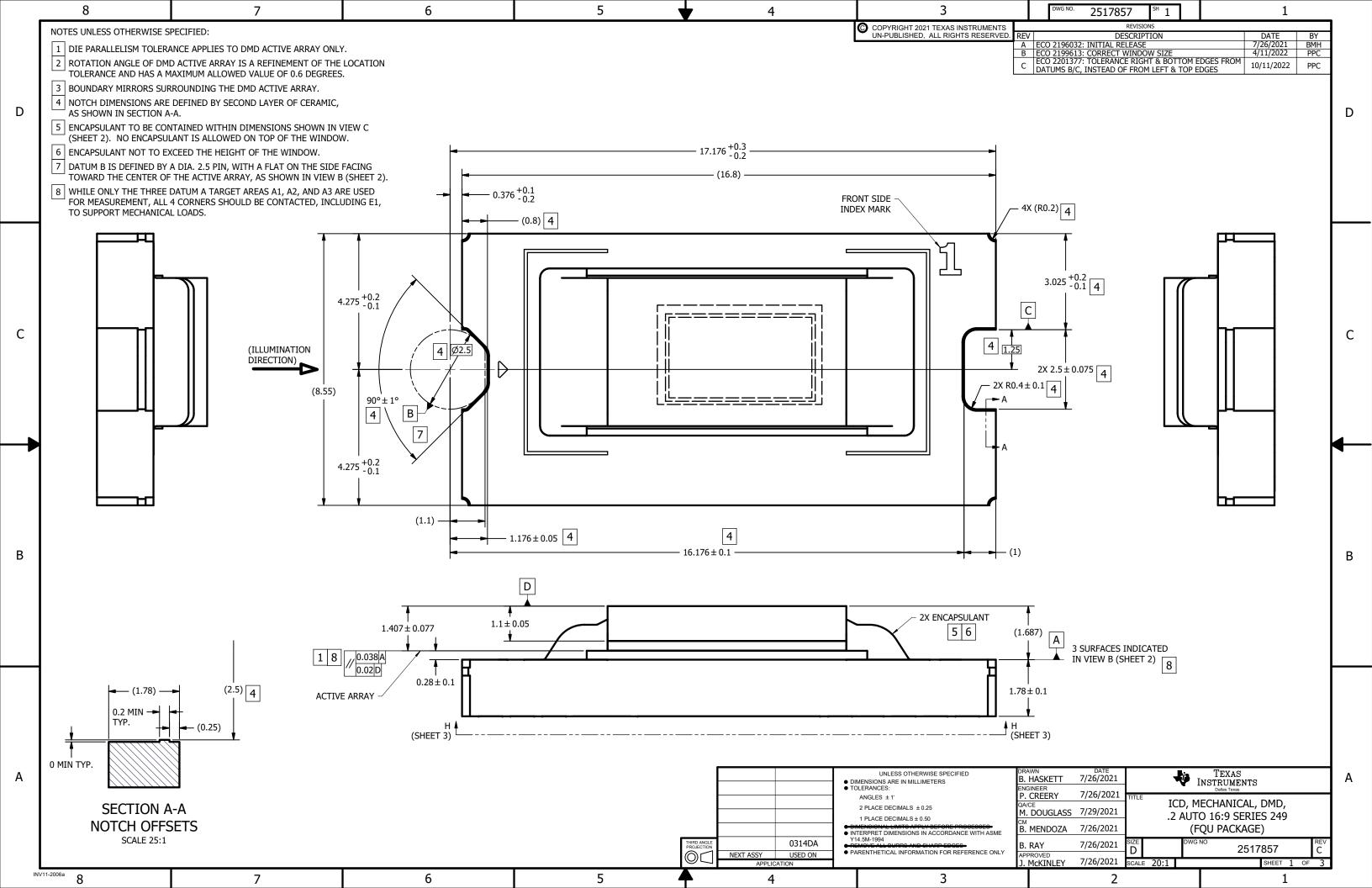
TRAY

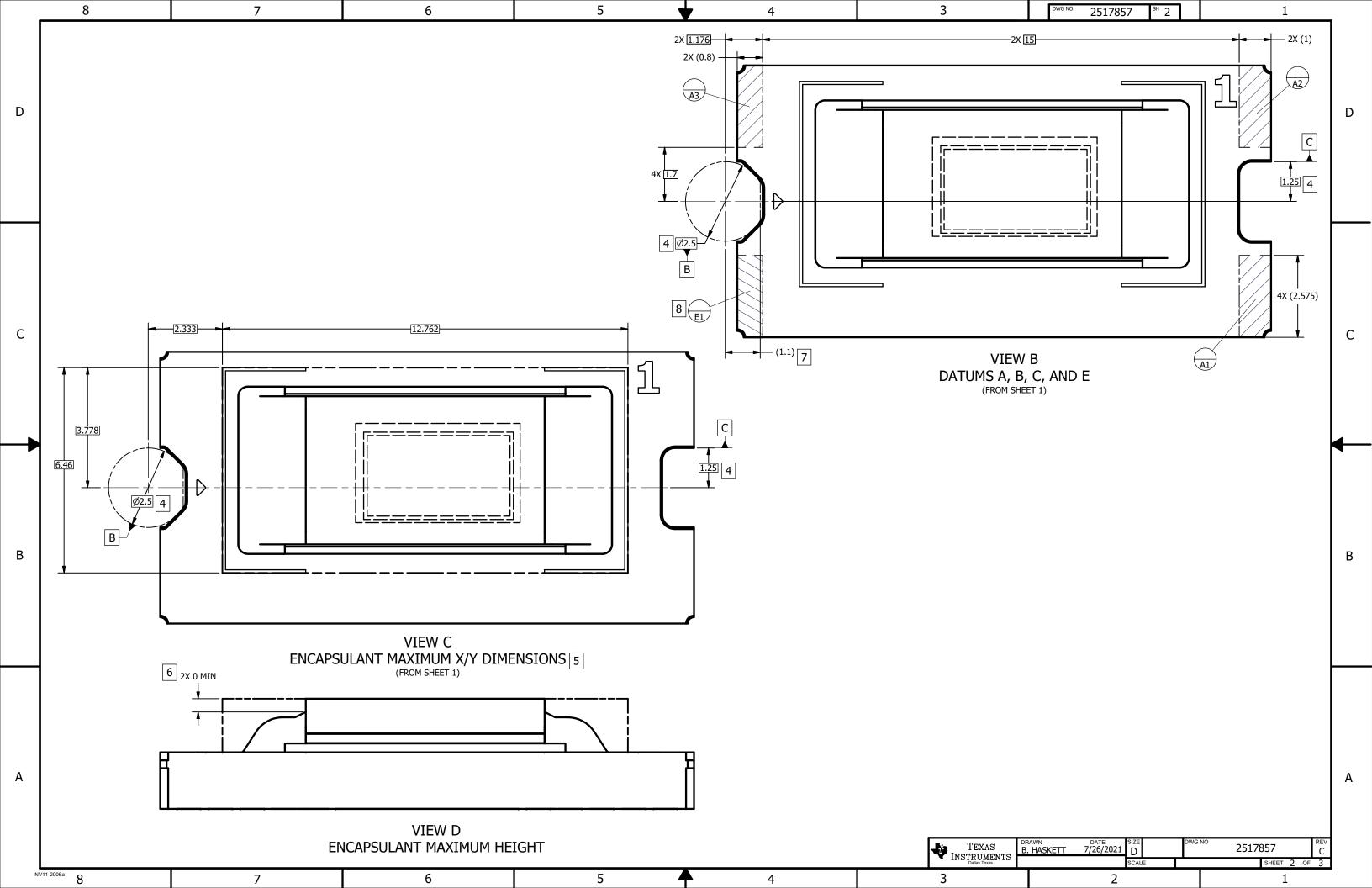


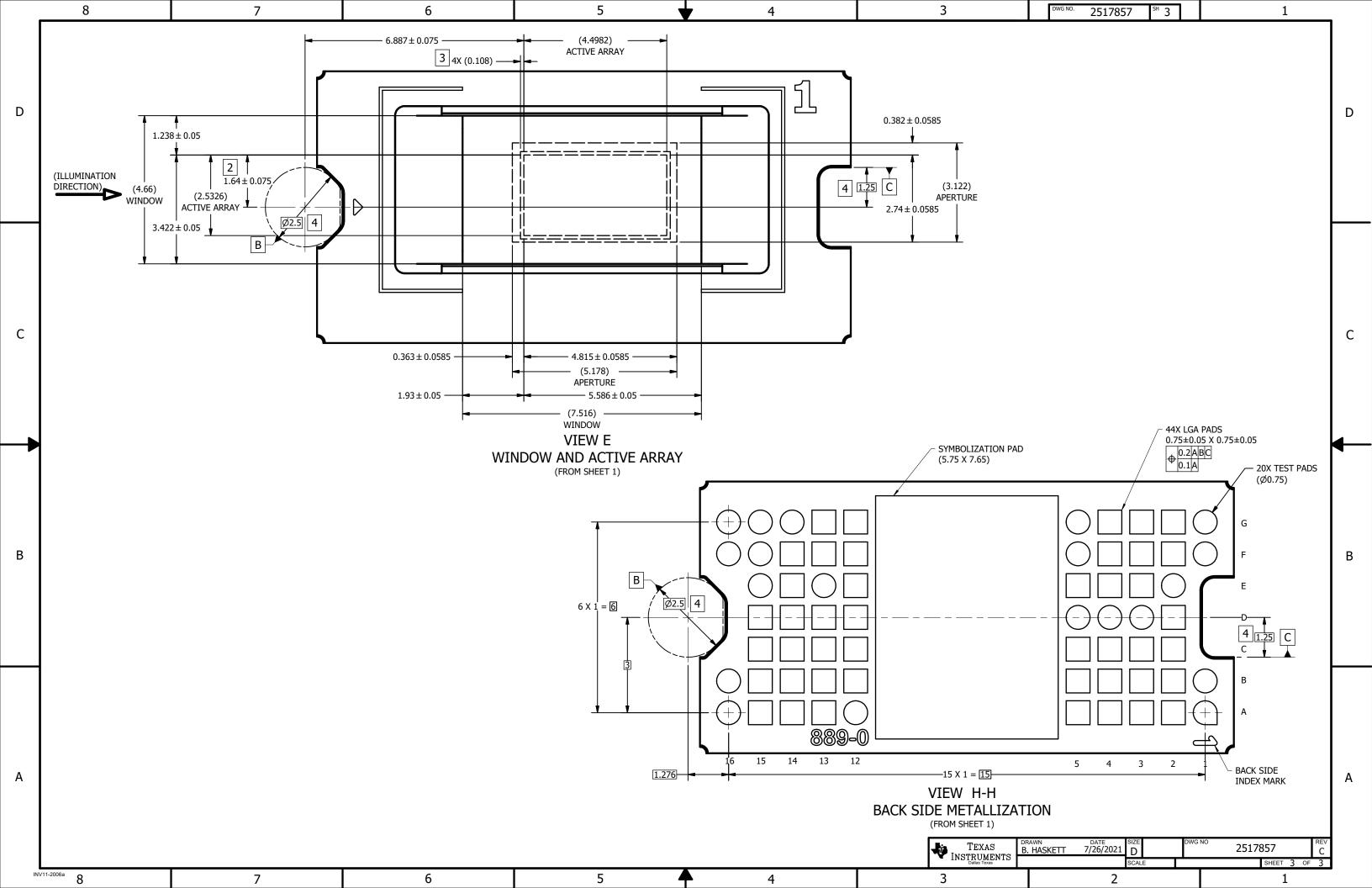
Chamfer on Tray corner indicates Pin 1 orientation of packed units.

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	Unit array matrix	Max temperature (°C)	L (mm)	W (mm)	Κ0 (μm)	P1 (mm)	CL (mm)	CW (mm)
DLP2021AFQUQ1	FQU	CLGA	64	126	9 x 14	150	315	135.9	12190	21.9	15.15	16.95
DLP2021AFQUQ1.A	FQU	CLGA	64	126	9 x 14	150	315	135.9	12190	21.9	15.15	16.95







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